# FAIRCHILD

SEMICONDUCTOR

### December 2008

# FDS8882 N-Channel PowerTrench<sup>®</sup> MOSFET 30 V, 9 A, 20.0 m $\Omega$

## Features

- Max  $r_{DS(on)} = 20.0 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 9 \text{ A}$
- Max  $r_{DS(on)}$  = 22.5 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 8 A
- High performance trench technology for extremely low r<sub>DS(on)</sub> and fast switching
- High power and current handling capability
- Termination is Lead-free and RoHS Compliant

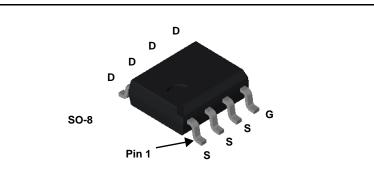


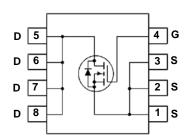
## **General Description**

The FDS8882 has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance.

## Applications

- Notebook System Regulators
- DC/DC Converters





## MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
I <sub>D</sub>	Drain Current -Continuous			9	•	
	-Pulsed		21	— A		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	32	mJ	
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.5	14/	
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1b)	1.0	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temper	ature Range		-55 to +150	°C	

### **Thermal Characteristics**

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Note 1)	25	°C ///
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	°C/W

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS8882	FDS8882	SO8	13 "	12 mm	2500 units

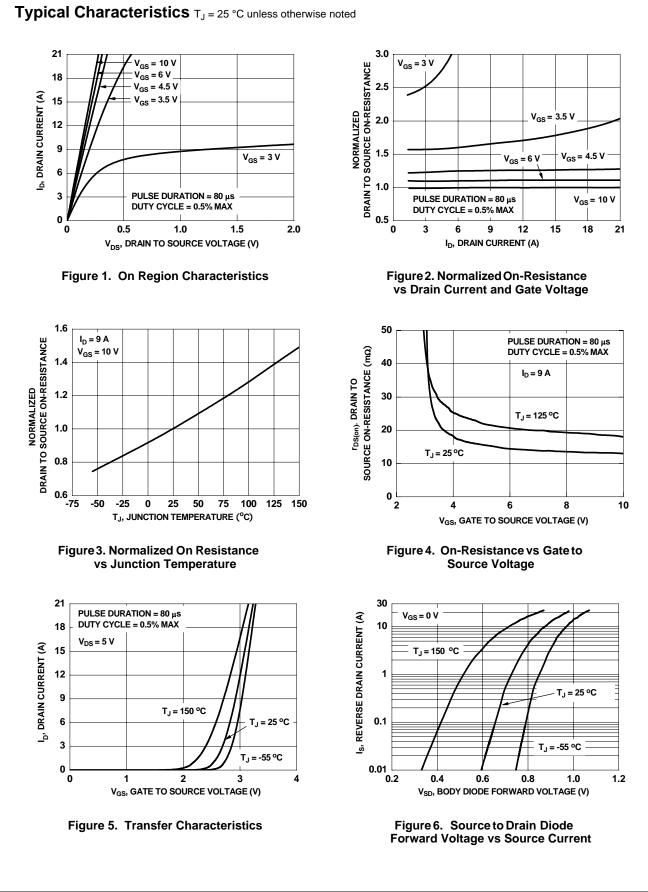
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	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	30			V
$\Delta BV_{DSS}$ $\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , referenced to 25 °C		4		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
	cteristics		1	1	1	1
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	1.0	1.7	3.0	V
$\Delta V_{GS(th)}$	Gate to Source Threshold Voltage		1.0	1.7	0.0	•
$\frac{\Delta V GS(th)}{\Delta T_J}$	Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-6		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9 A		13.2	20.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 8 A		16.6	22.5	mΩ
20(01)		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9 A, T <sub>J</sub> =125 °C		18.5	28.0	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 V, I_D = 9 A$		36		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance			707	940	pF
	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,		138	185	pF
C <sub>oss</sub>	Reverse Transfer Capacitance	f = 1 MHz		88	135	pF
C <sub>rss</sub> R <sub>g</sub>	Gate Resistance			1.8	155	Ω
*				1.0		22
Switching	Characteristics					1
t <sub>d(on)</sub>	Turn-On Delay Time			7	14	ns
t <sub>r</sub>	Rise Time	$V_{DD}$ = 15 V, I <sub>D</sub> = 9 A, - V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		3	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			19	35	ns
t <sub>f</sub>	Fall Time			4	10	ns
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		14	20	nC
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$ $V_{GS} = 0 V \text{ to } 5 V$ $V_{DD} = 15 V,$ $I_D = 9 A$		8	11	nC
Q <sub>gs</sub>	Gate to Source Charge	1 <u>0</u> = 3 A		2.2		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			2.8		nC
Drain-Sou	urce Diode Characteristics					
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 9 A		0.8	1.2	
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.1 A$		0.7	1.2	V
t <sub>rr</sub>	Reverse Recovery Time			17	31	ns
	Reverse Recovery Charge	I <sub>F</sub> = 9 A, di/dt = 100 A/μs		6	12	nC

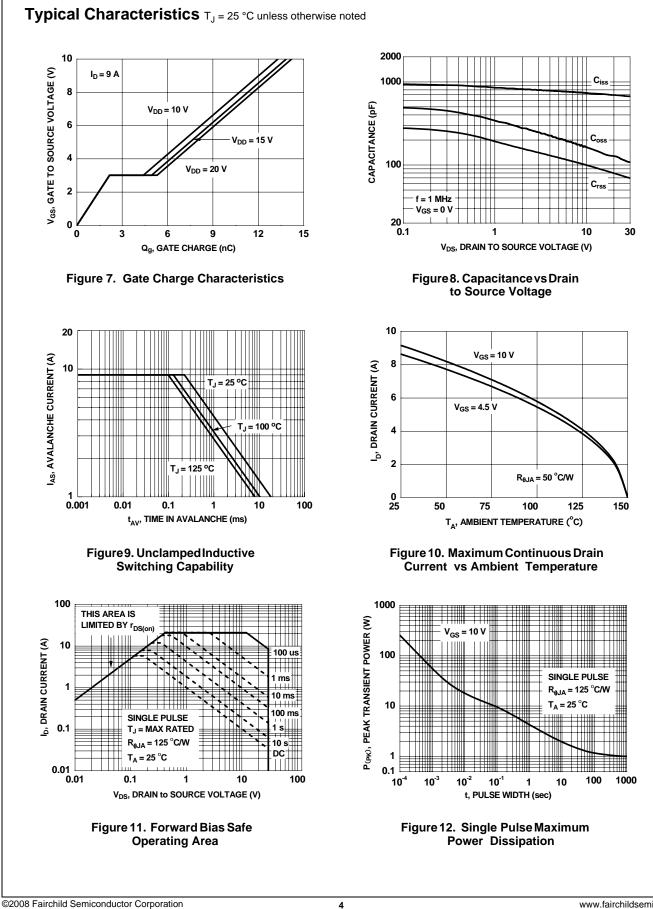
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2. Pulse Test: Pulse Width < 300  $~\mu s,$  Duty cycle < 2.0%. 3. Starting T\_J = 25 °C, ~L = 1 mH, I\_{AS} = 8 A, V\_{DD} = 27 V, V\_{GS} = 10 V.

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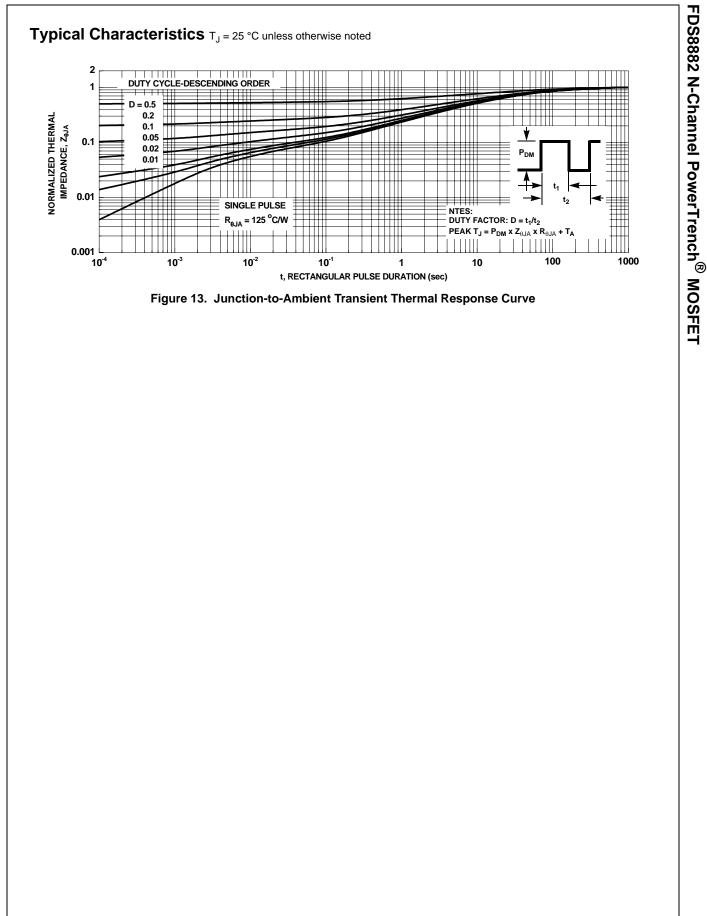
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FDS8882 Rev.C





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